Search Notes



| Application/Control N | 10 |
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Applicant(s)/Patent Under Reexamination MURAMATSU ET AL.

Examiner

Art Unit

Kim-Kwok CHU

2627

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 369 | 47.36 | 4/22/2010 | kc |
| 369 | 47.21 | 4/22/2010 | kc |
| 369 | 53.15 | 4/22/2010 | kc |
| 369 | 53.17 | 4/22/2010 | kc |
| 369 | 53.3 | 4/22/2010 | kc |
| 369 | 275.3 | 4/22/2010 | kc |
| 711 | 4 | 4/22/2010 | kc |
| 711 | 112 | 4/22/2010 | kc |
| 711 | 154 | 4/22/2010 | kc |
| 369 | 275.4 | 4/22/2010 | kc |
| 369 | 47.47 | 4/22/2010 | kc |
| 369 | 59.25 | 4/22/2010 | kc |

| SEARCH NOTES | | | |
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| Search Notes | Date | Examiner | |
| East Search Updated | 4/22/2010 | kc | |

| INTERFERENCE SEARCH | | | |
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